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Imaging performance of the EDET-80k detector

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Outline

- Introduction: EDET-80 detector for fast TEM imaging
- Simulation of EDET-80 response
- Non-spatial capabilities of EDET-80: Electron counting
 - Scenario 1: Infinit pixel
 - Scenario 2: Pixel and cluster illumination
 - Scenario 3: Pixel and homogenous illumination
 - Detective Quantum Efficiency: $DQE(0)$
- Spatial capabilities of EDET-80
 - Modulation Transfer Function (MTF)
 - DQE versus spatial frequency: $DQE(f)$
- EDET calibration with Cd-109: simulation vs. measurement
- Conclusion and outlook

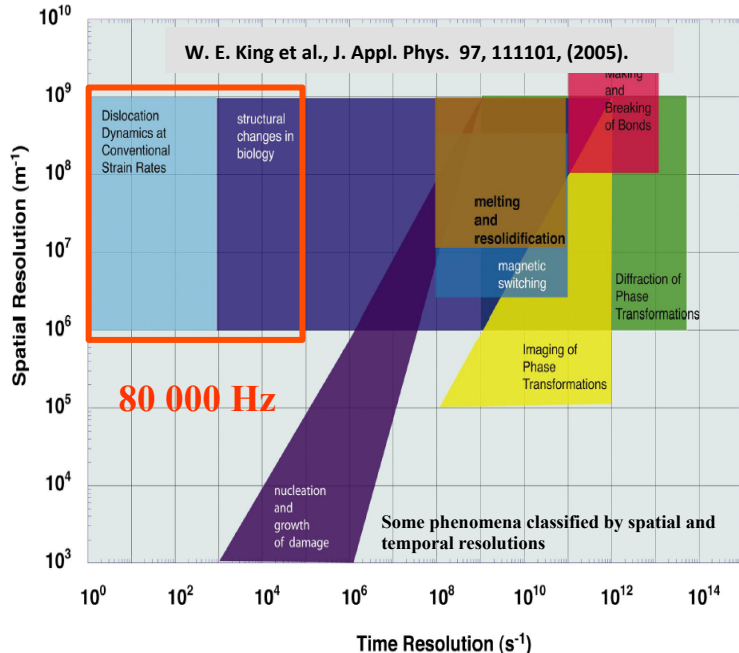


Introduction: EDET- 80 detector for fast TEM imaging

- **Goal: Real space and time imaging using TEM**
(e.g, fast molecular dynamics in biology)



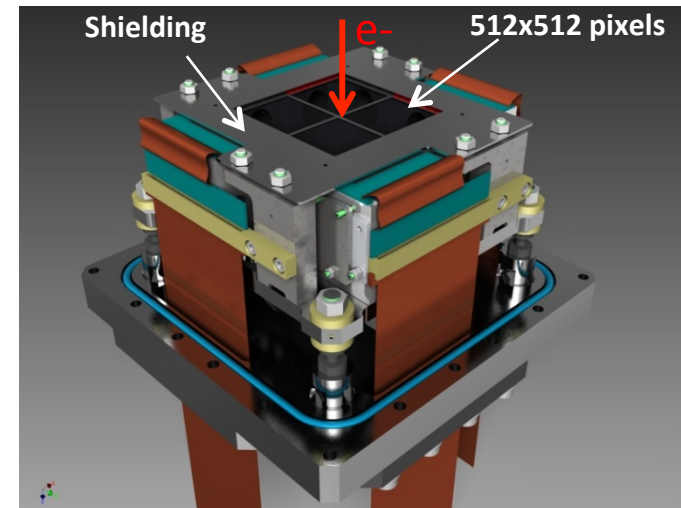
Large area detector with high speed:
EDET-80kHz



- **Readout time 100 ns/row (4 rows in parallel, t=12.8μs)**
- 100 frames ⇒ movie of 1.28 ms
- **Single electron resolution ⇒ low dose applications**
 - **Direct electron detection**
 - **High DQE:** key for radiation sensitive samples
- **Large dynamic range ⇒ High intensity**
 - Thin sensor (50 μm) with 100 % detection efficiency
 - Digitization with 8 bit resolution

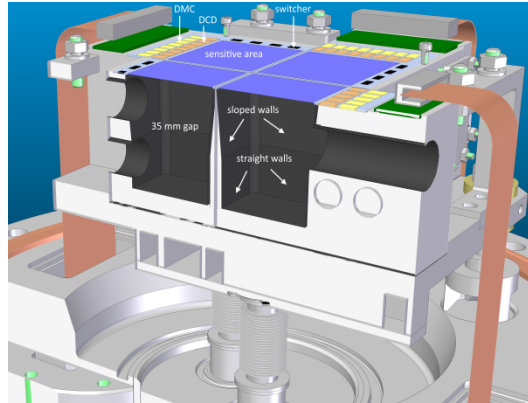
Tools:

- **Technology:** Non-linear DEPFET
- **Monte Carlo simulation:** Detector modeling

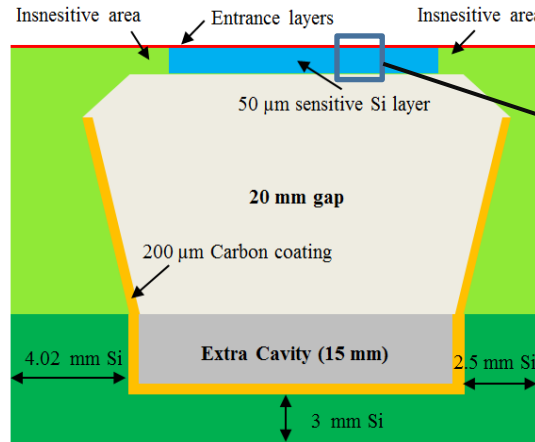


Simulation of EDET-80 response

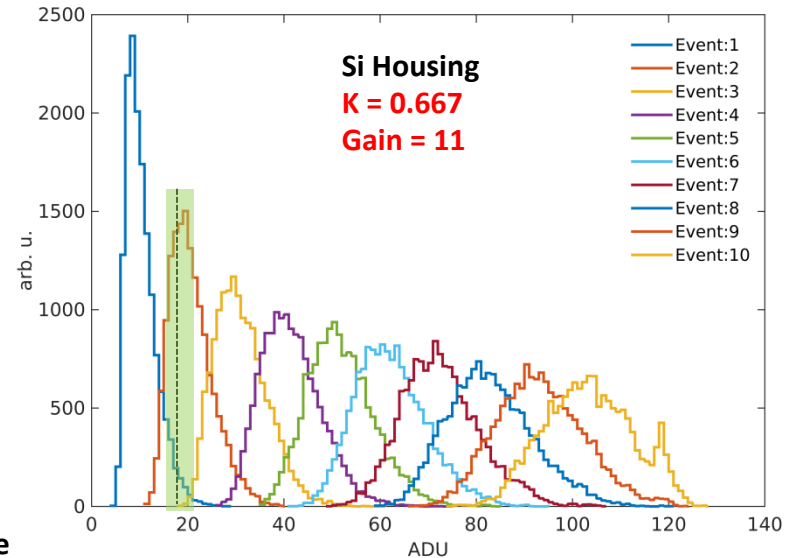
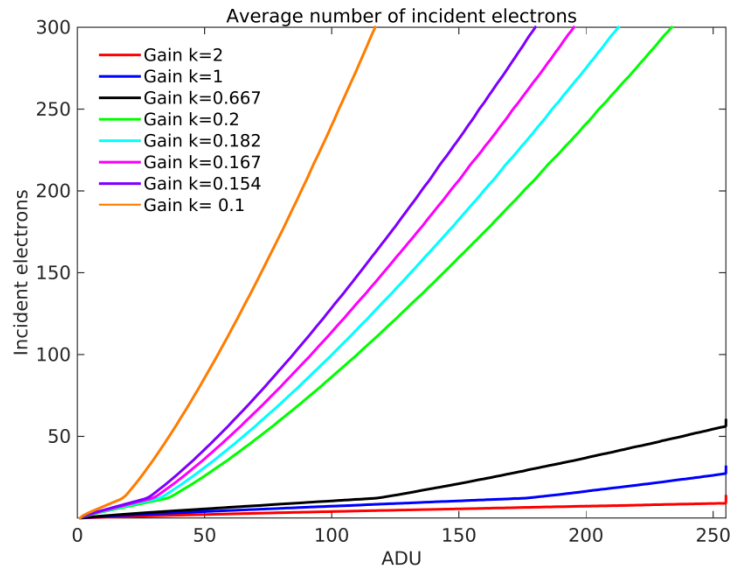
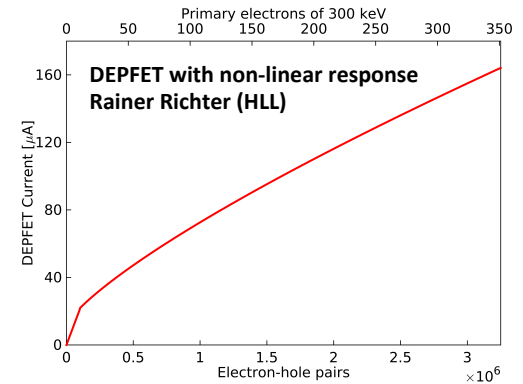
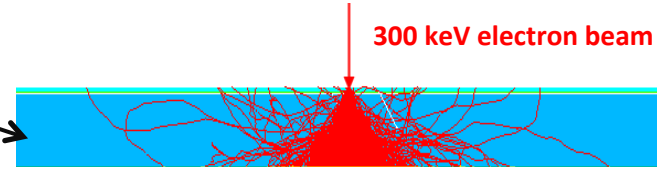
Dynamic range & single electron resolution



EDET CAD design



Geometry for lowest backscattering



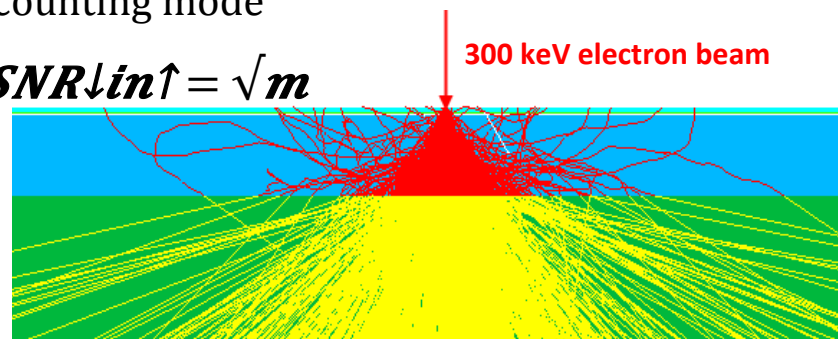
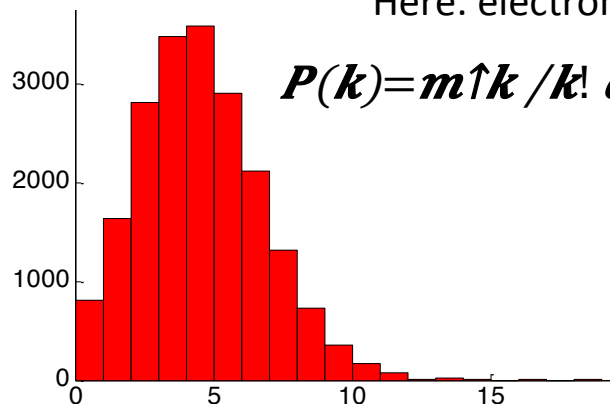
➤ High : low dose application ➤ Low gains: large dynamic range

Non-spatial capabilities of EDET-80: Electron counting

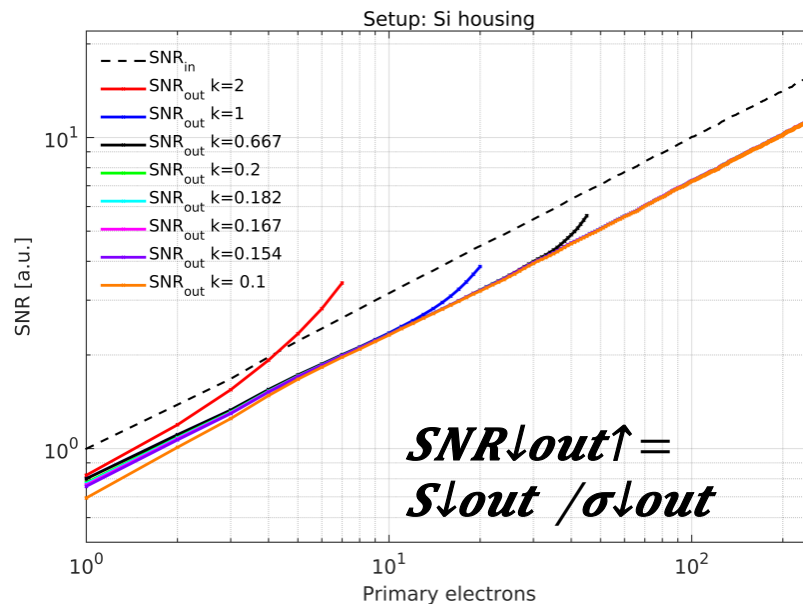
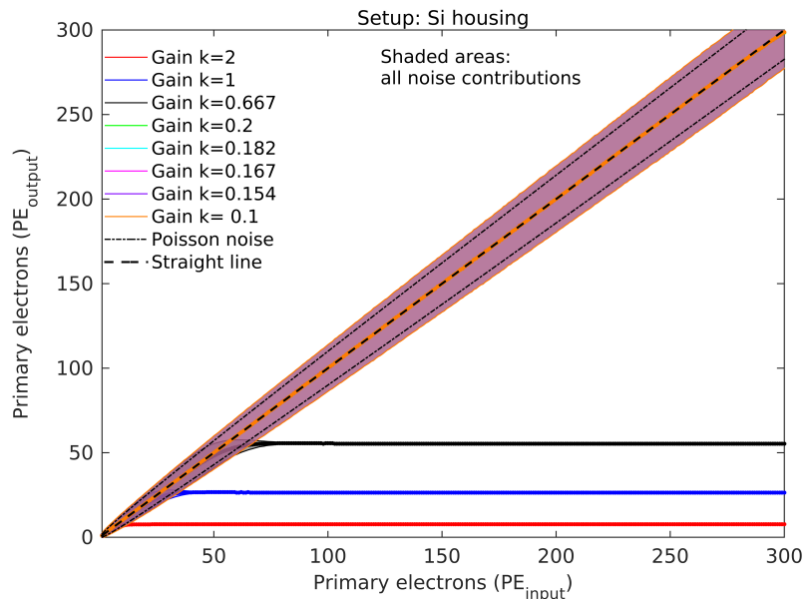
Scenario 1: Infinit pixel

Here: electron counting \neq counting mode

$$P(k) = m^k / k! e^{-m} \Rightarrow SNR_{in} = \sqrt{m}$$

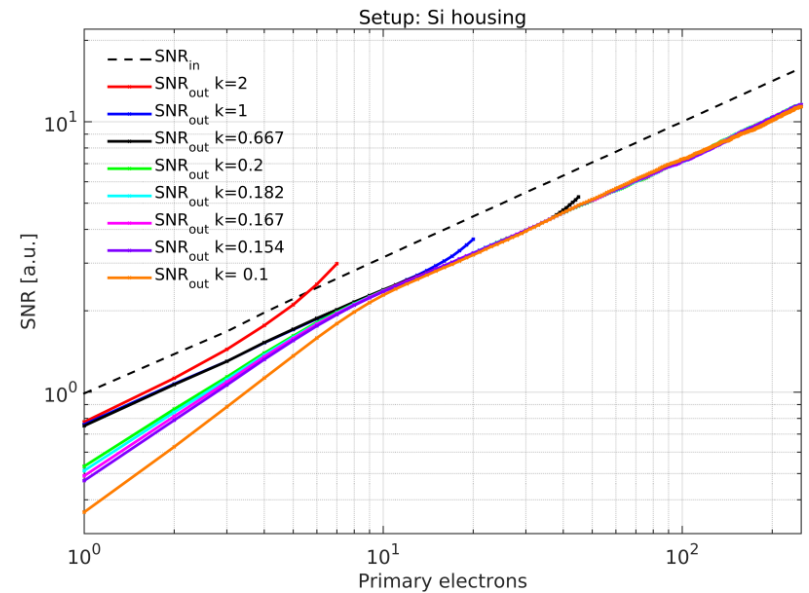
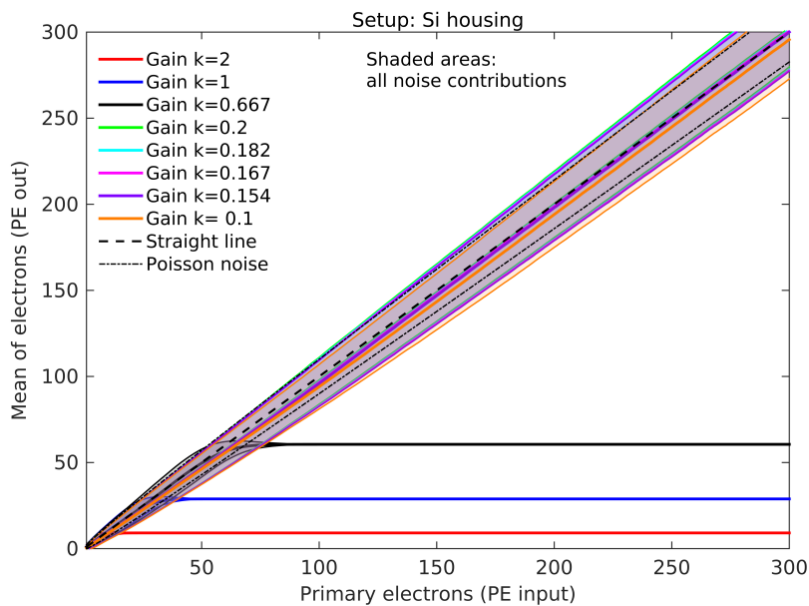
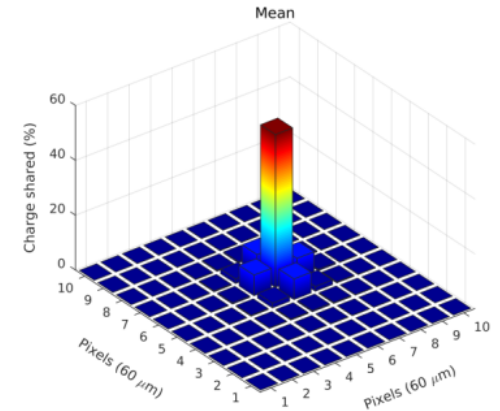
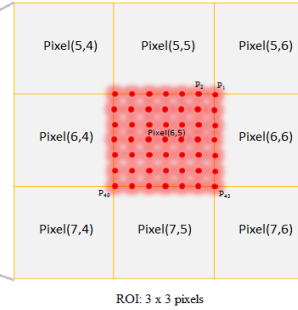
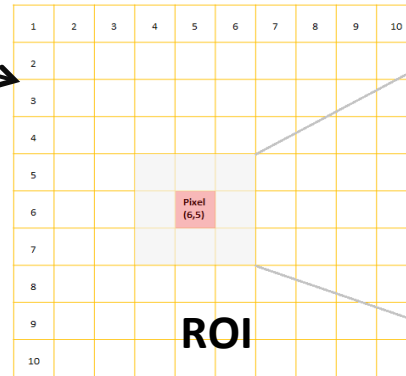
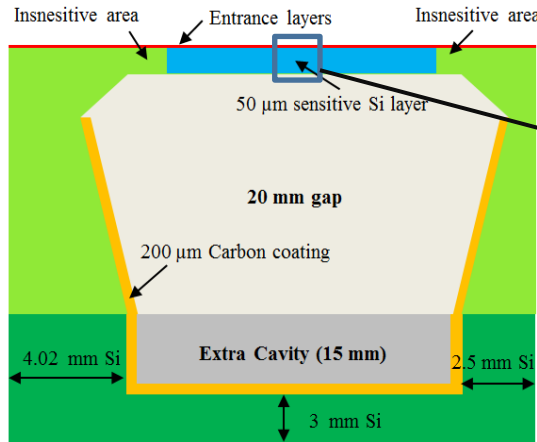


Counting



$$SNR_{out} = S_{out} / \sigma_{out}$$

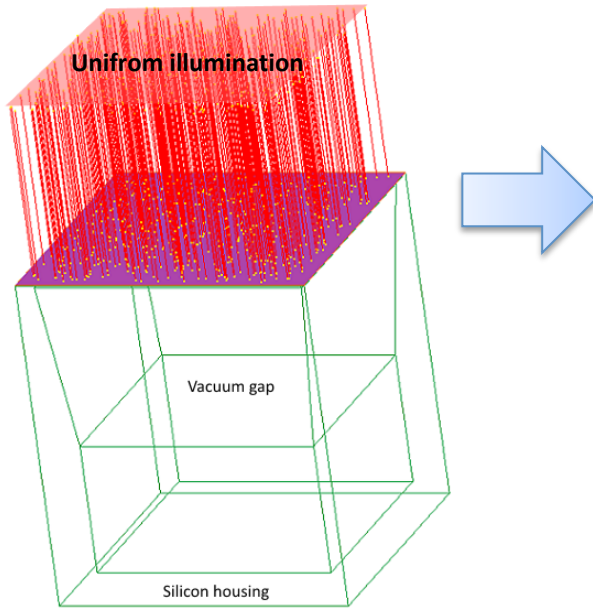
Scenario 2: Pixel and cluster illumination



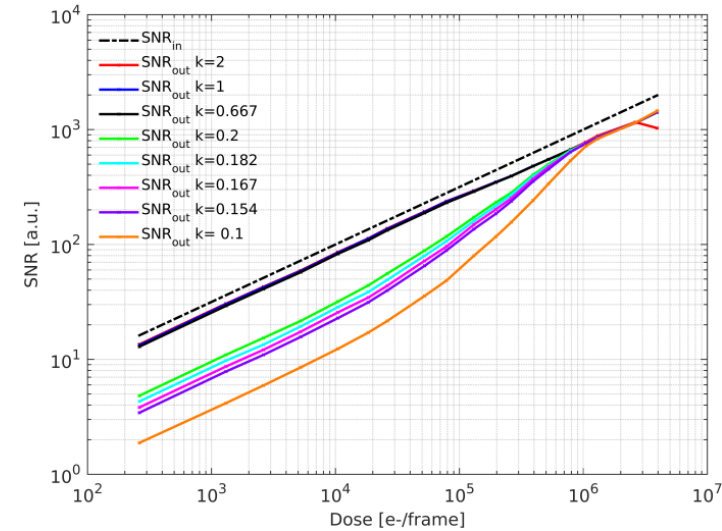
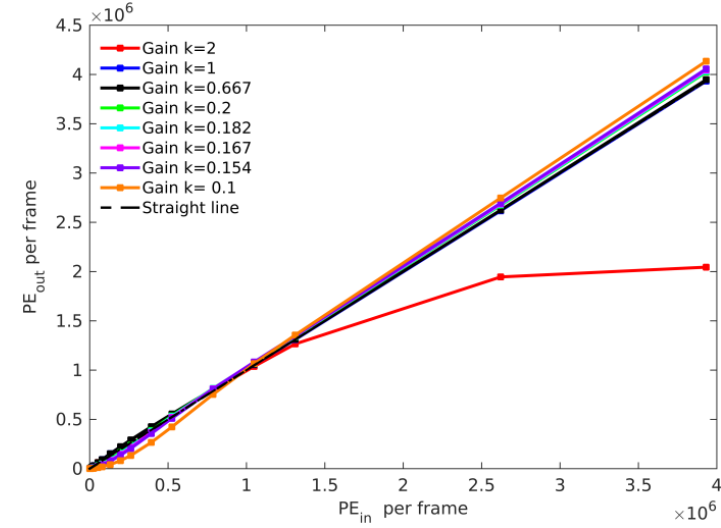
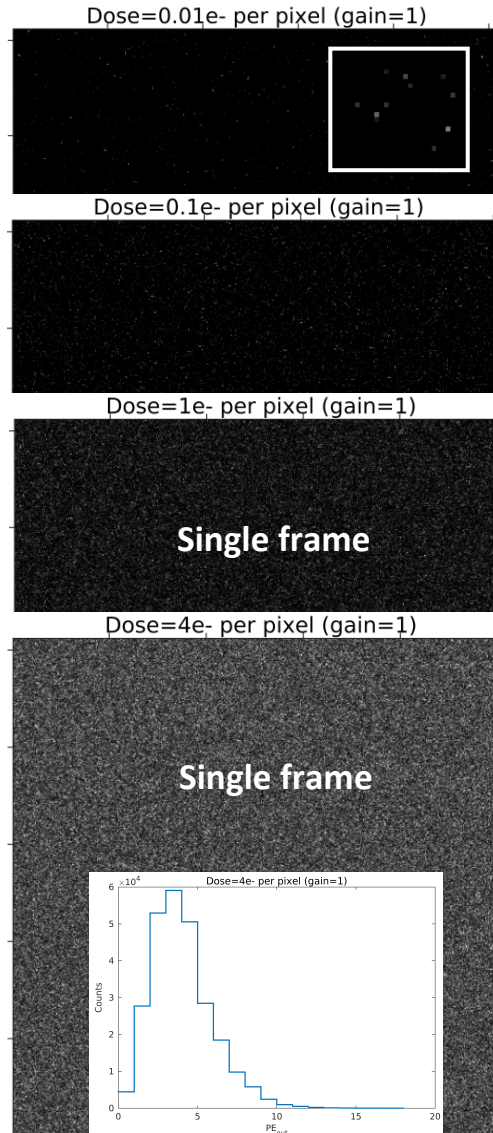
Scenario 3: Pixel and homogenous illumination

Low dose: Single event resolution

- Low dose: Single event resolution
- High dose: Events overlap.

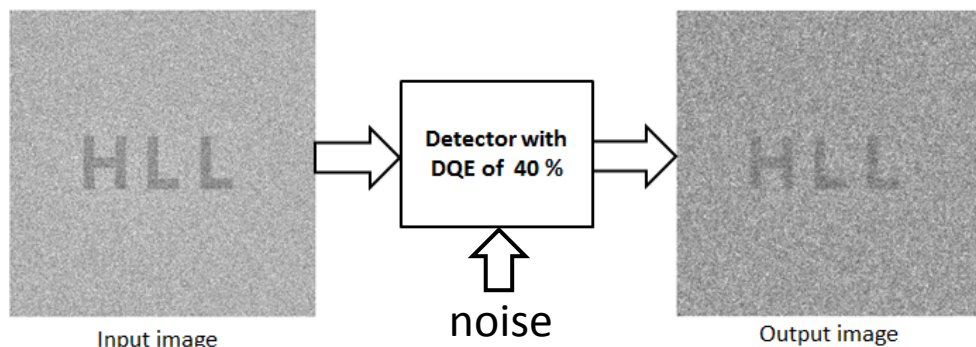


Dose: 0.001, 0.005, 0.01, 0.02, 0.04, 0.07, 0.1, 0.2, 0.3, 0.5, 0.75, 1, 1.5, 2, 3, 4, 5, 10, 15 electron per pixel



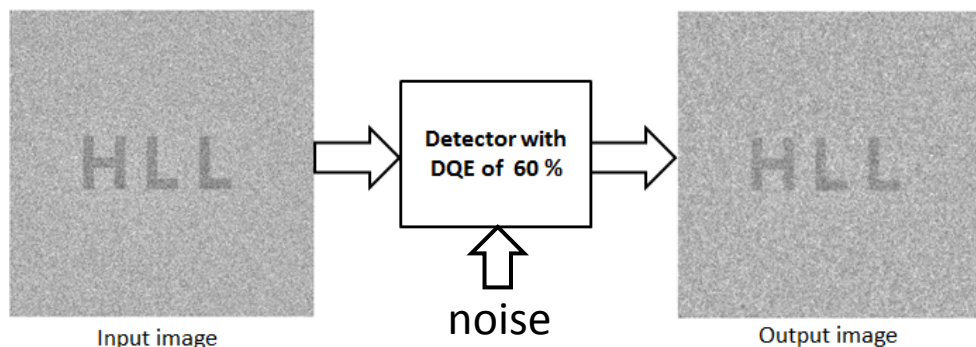
Detective Quantum Efficiency: DQE(0)

- **DQE** quantifies the detector performance in terms of adding extra noise by the detector to SNR_{in} . It combines **MTF** and **noise performance** of the detector.



$$DQE = \frac{SNR_{out}^2}{SNR_{in}^2} \leq 1$$

- **Higher DQE improves the image quality**



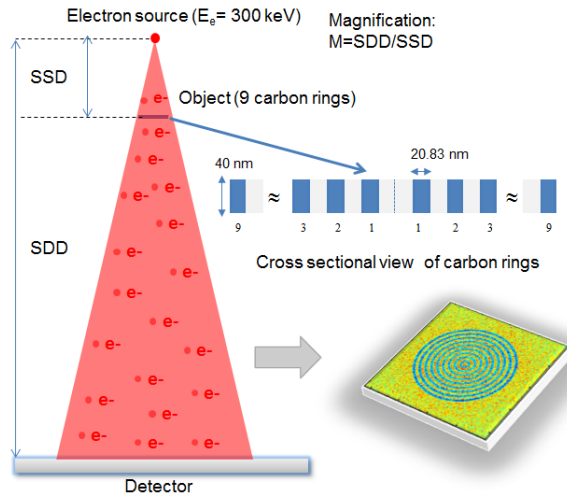
- The closer the DQE is to 1, the better the image quality

- Ideal detector

$$SNR_{out} = SNR_{in} \Rightarrow DQE = 1$$

⇒ **No information is lost**

- **Image quality:** depends on electron dose and the DQE of the detector

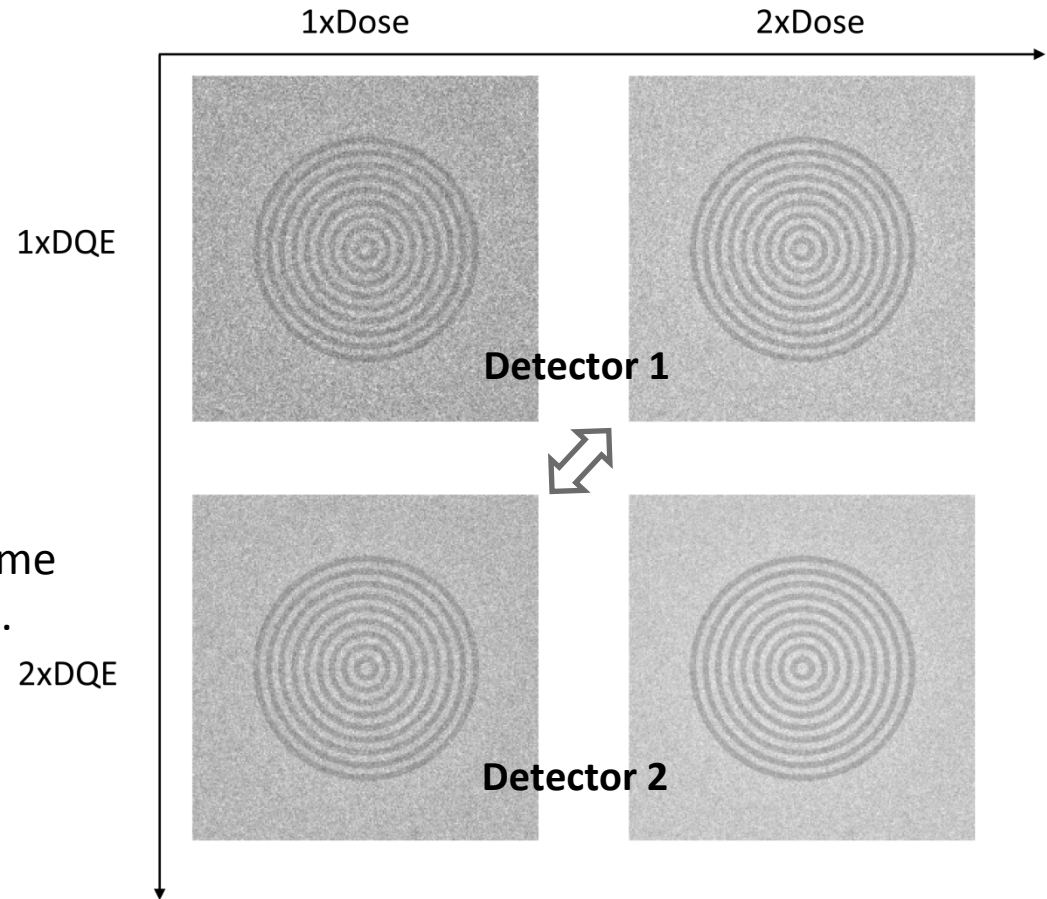


- Detector2 (2xDQE) achieves the same image quality with half the e- dose.

- **Radiation sensitive samples:**

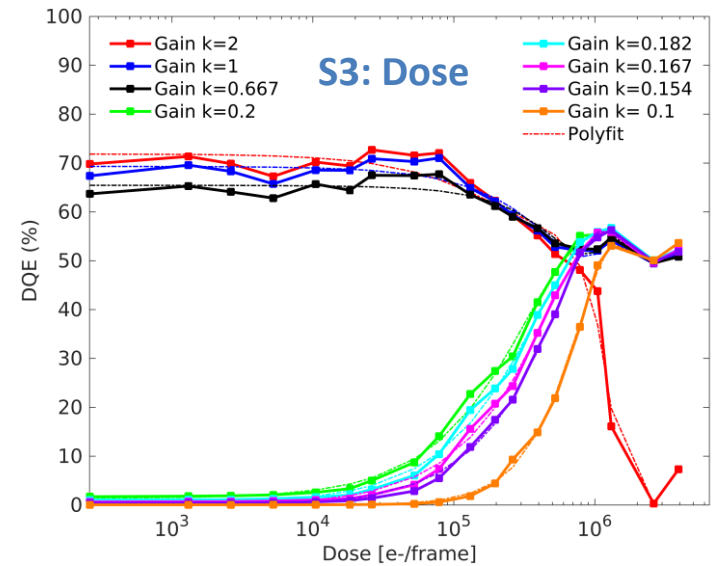
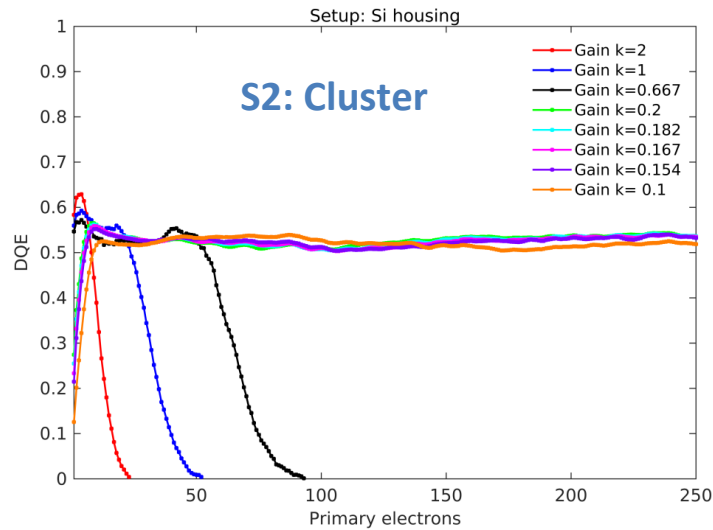
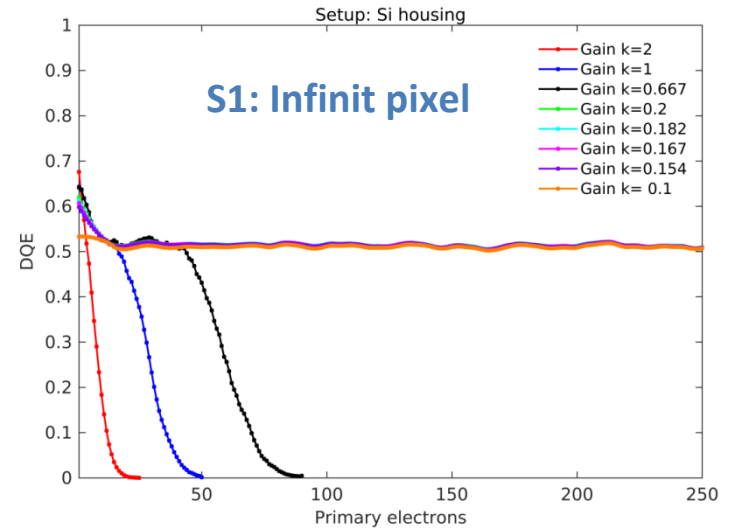
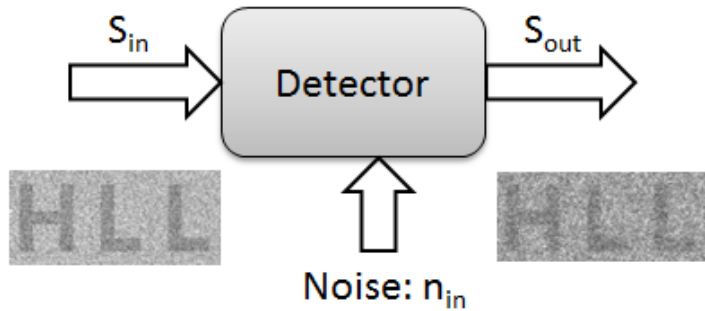


DQE is a key



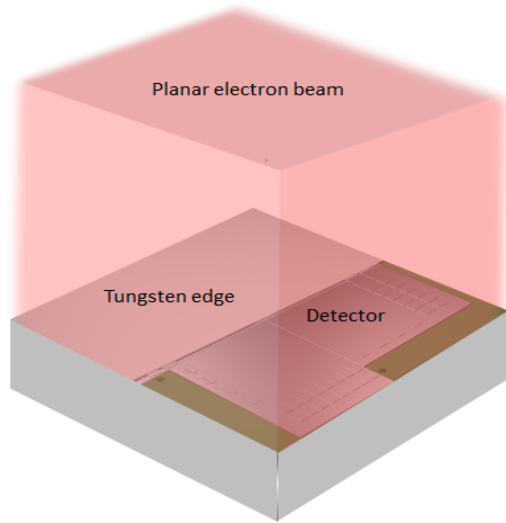
DQE at Zeros spatial frequency

$$DQE = \frac{SNR_{out}^2}{SNR_{in}^2}$$

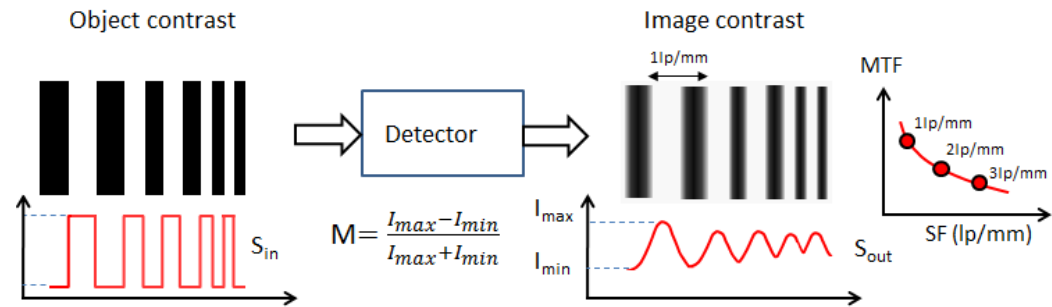


Spatial capabilities of EDET-80: Modulation Transfer Function (MTF)

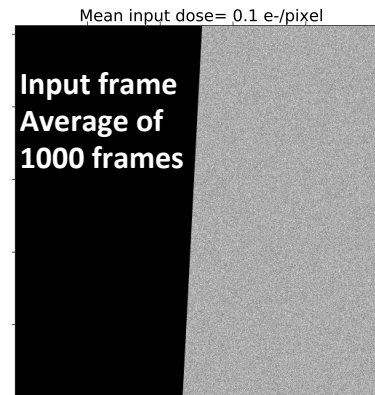
- **MTF** measures the ability of a detector to transfer signals of various spatial frequencies from the input to the output of the detector.
- **Higher MTF:** Better image spatial resolution and sharpness
- **MTF=1:** Ideal detector



Slanted edge method

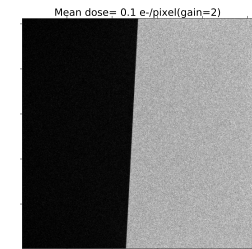


Input

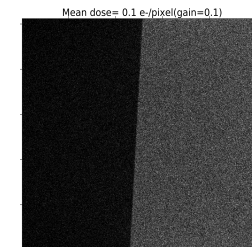


Poisson only

Output



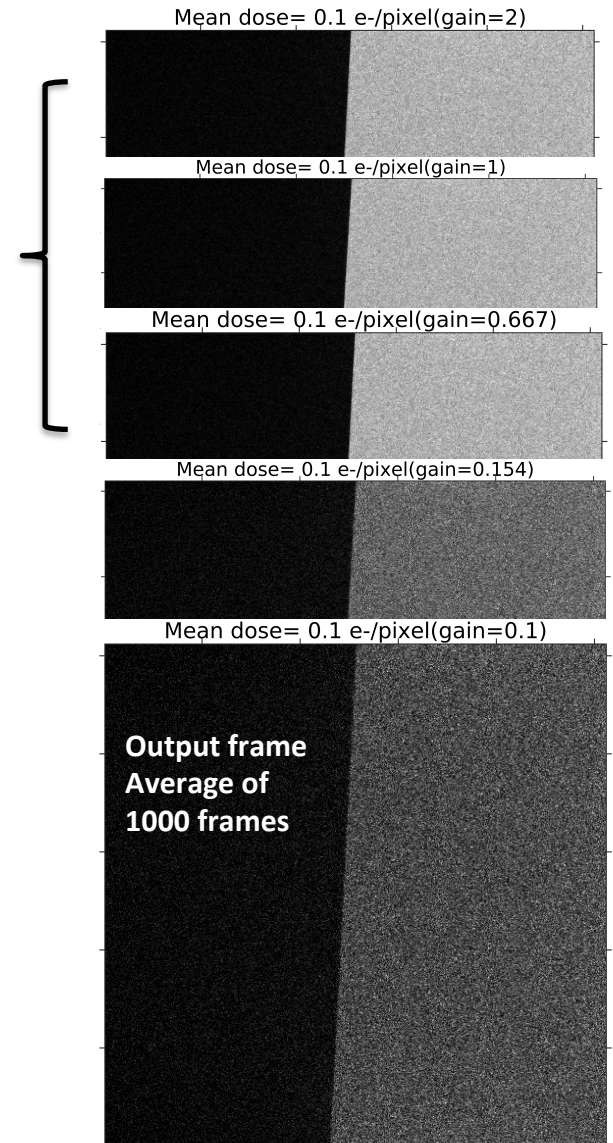
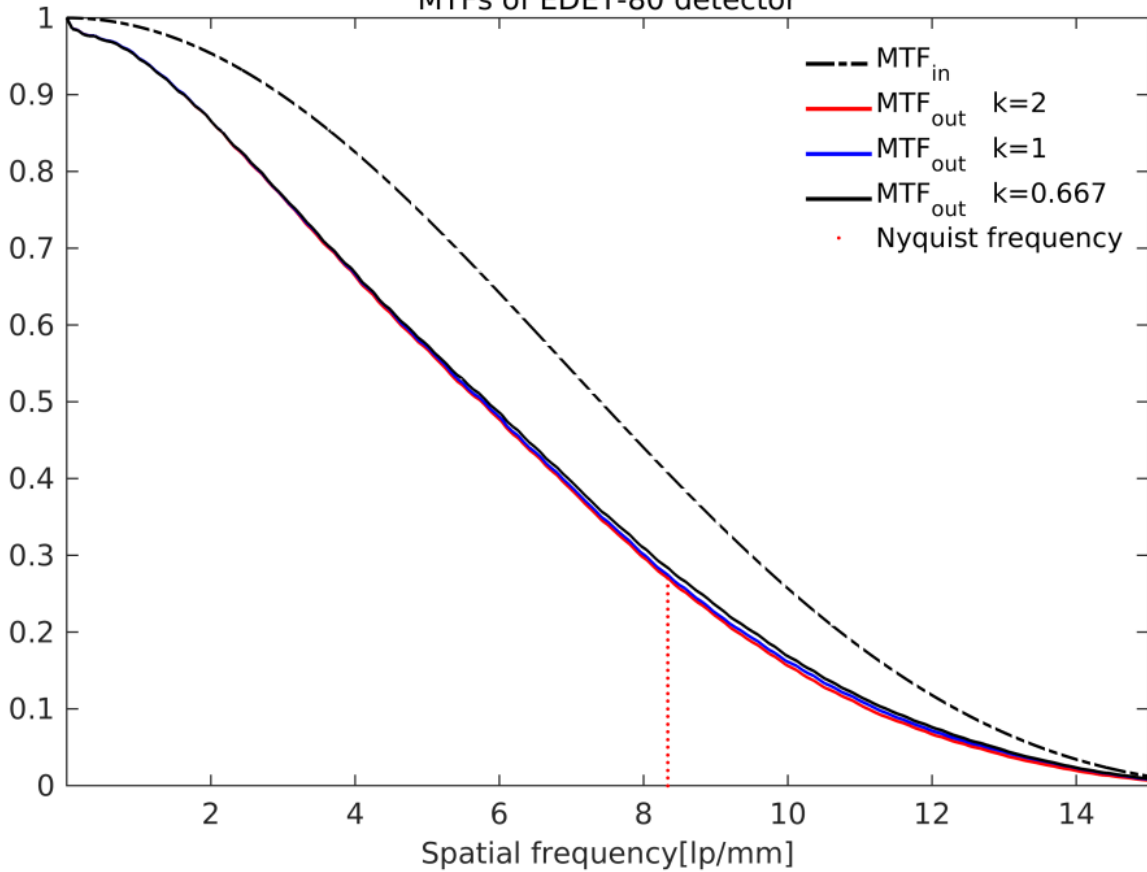
High gain



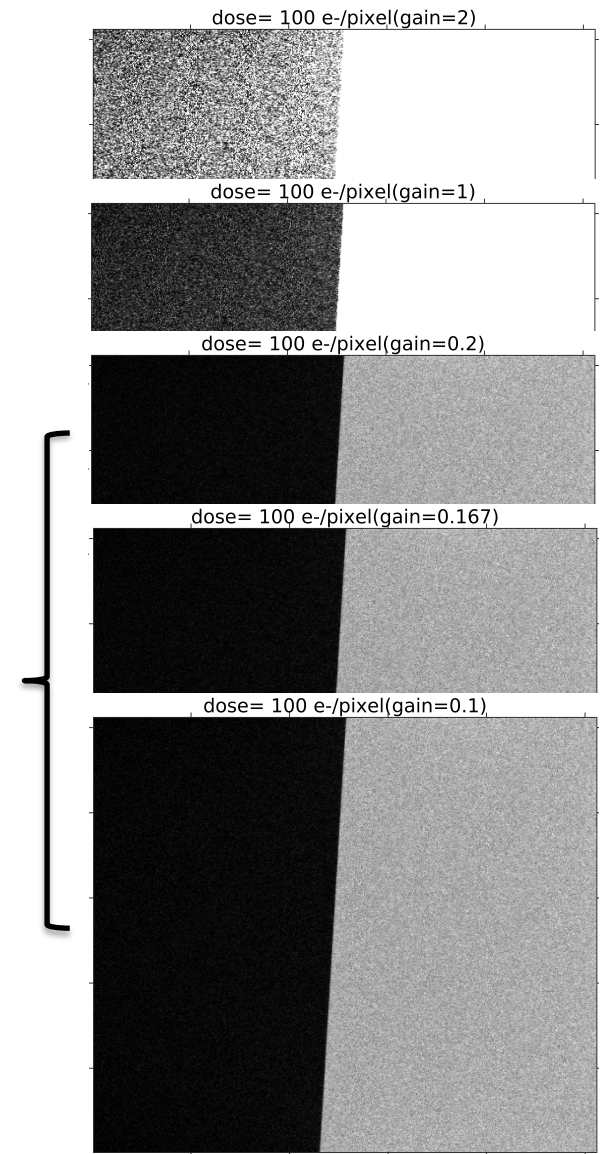
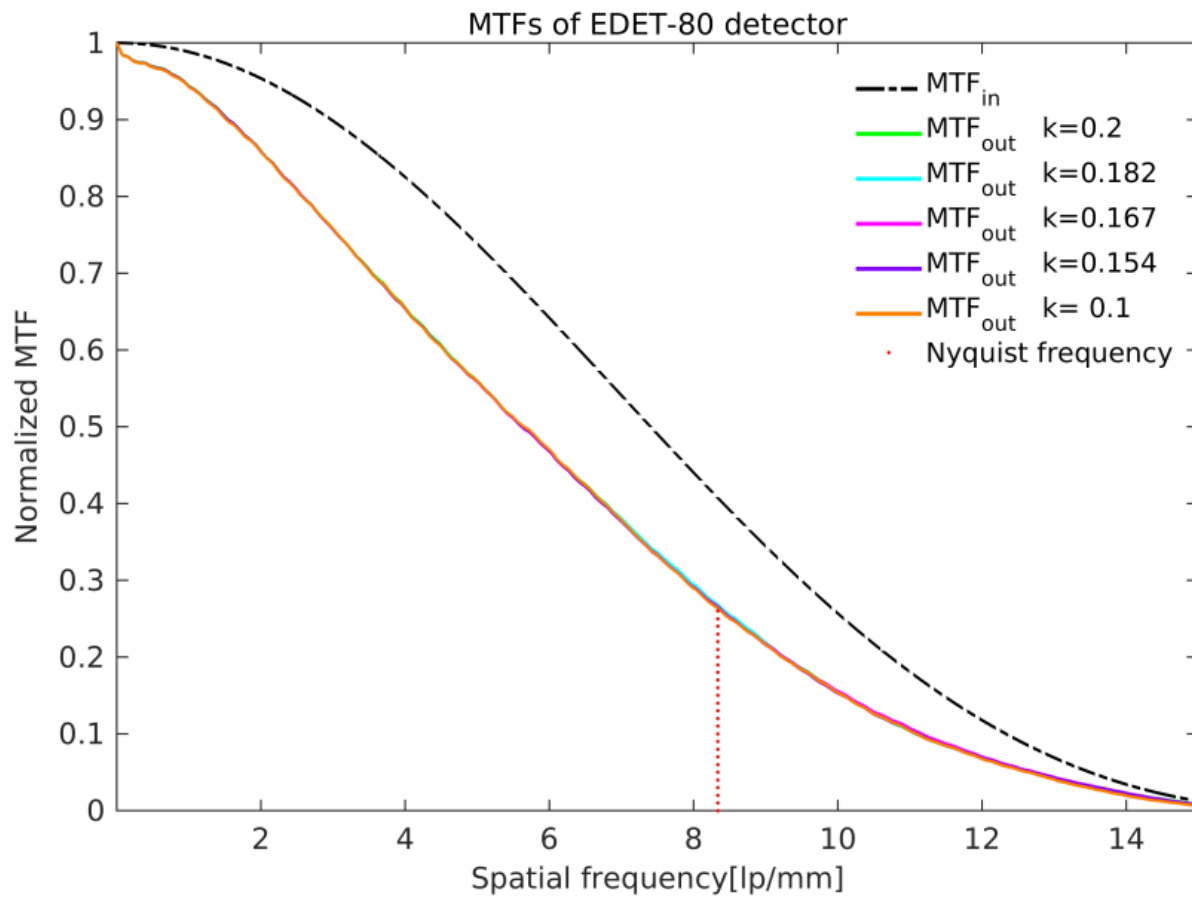
Low gain

■ MTF at high gain settings (Low dose applications)

MTFs of EDET-80 detector

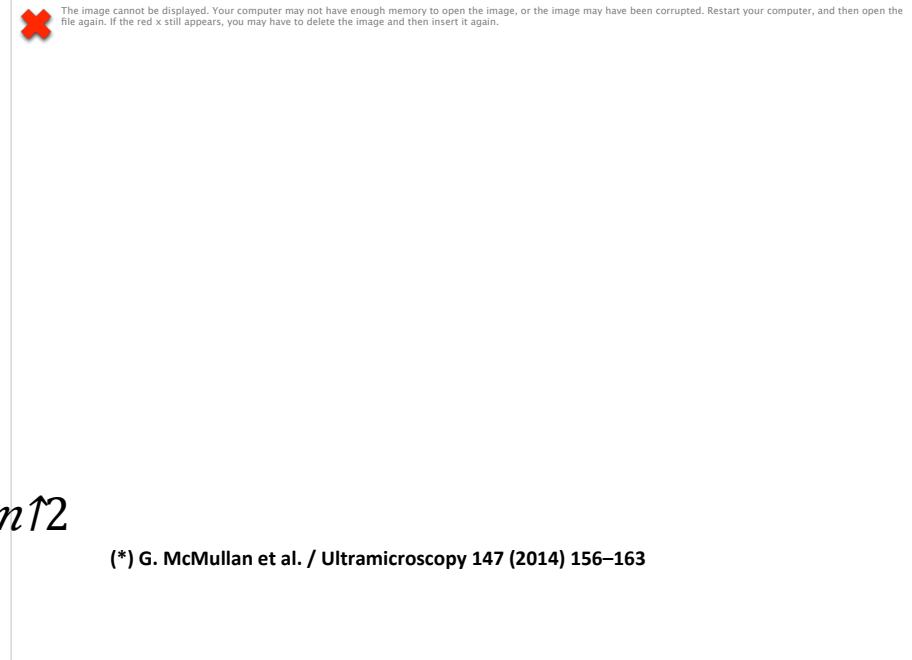
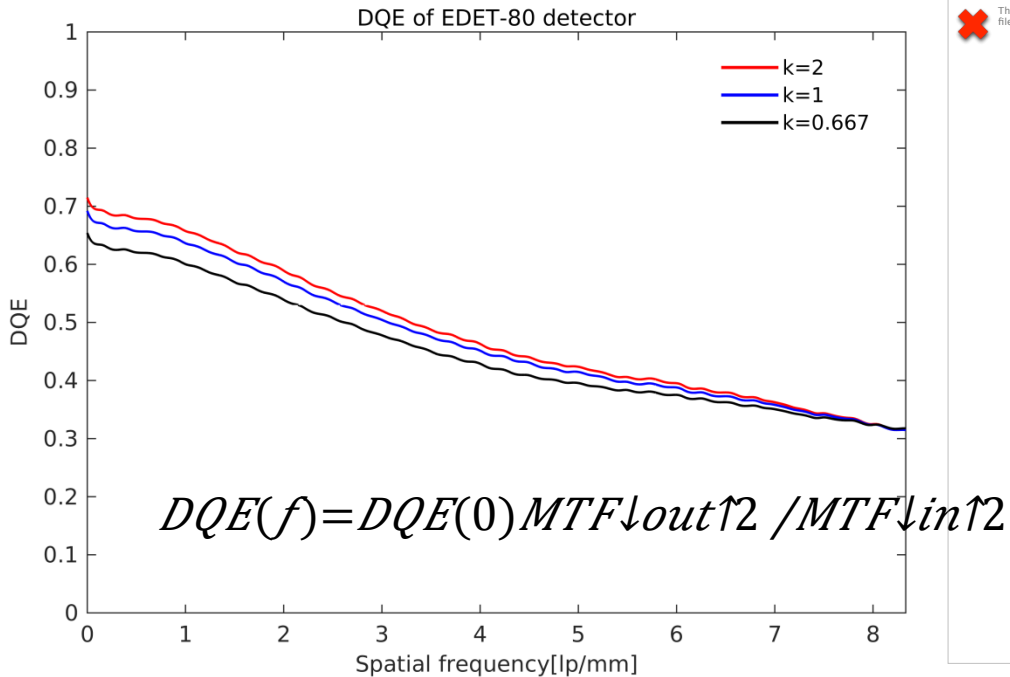


- MTF at low gain settings (Large dynamic range)



DQE versus spatial frequency: DQE(f)

■ Comparison with other commercially available detectors



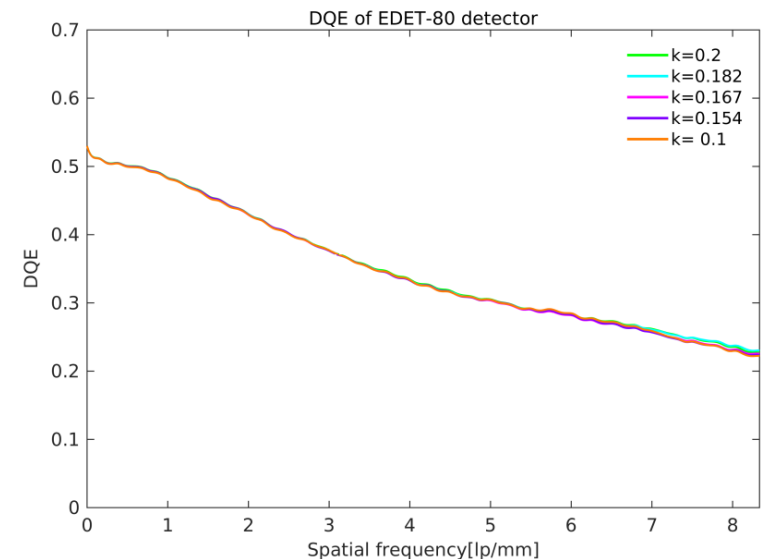
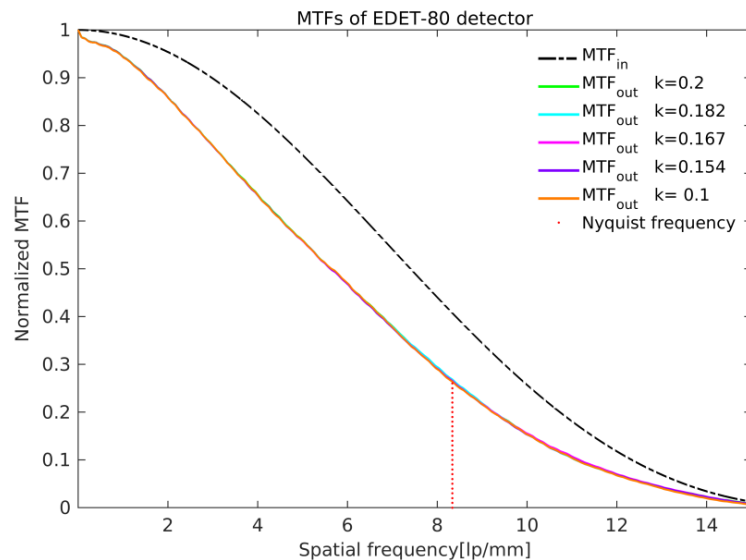
- All detectors are better than films and can capture movies
- These results demonstrate the suitability of high gain settings (k=2, 1, 0.667) for low-electron dose applications.
- EDET-80 shows great promise for low-dose TEM applications



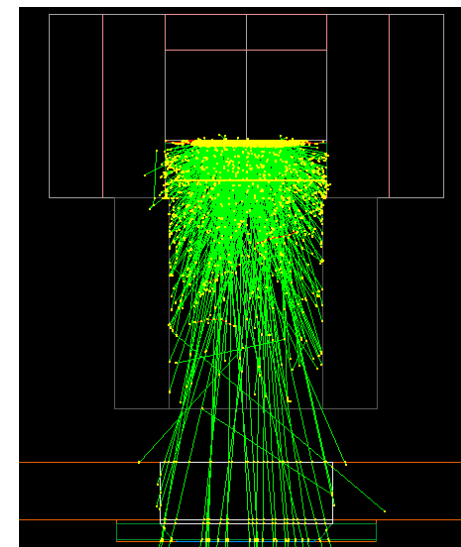
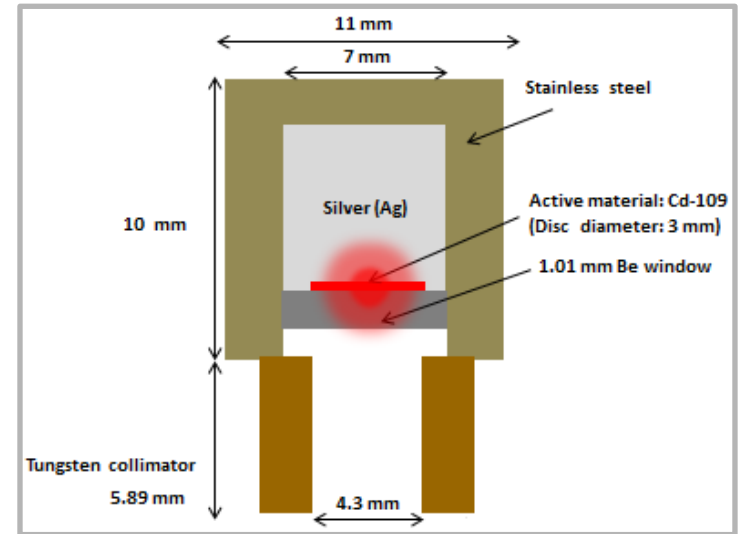
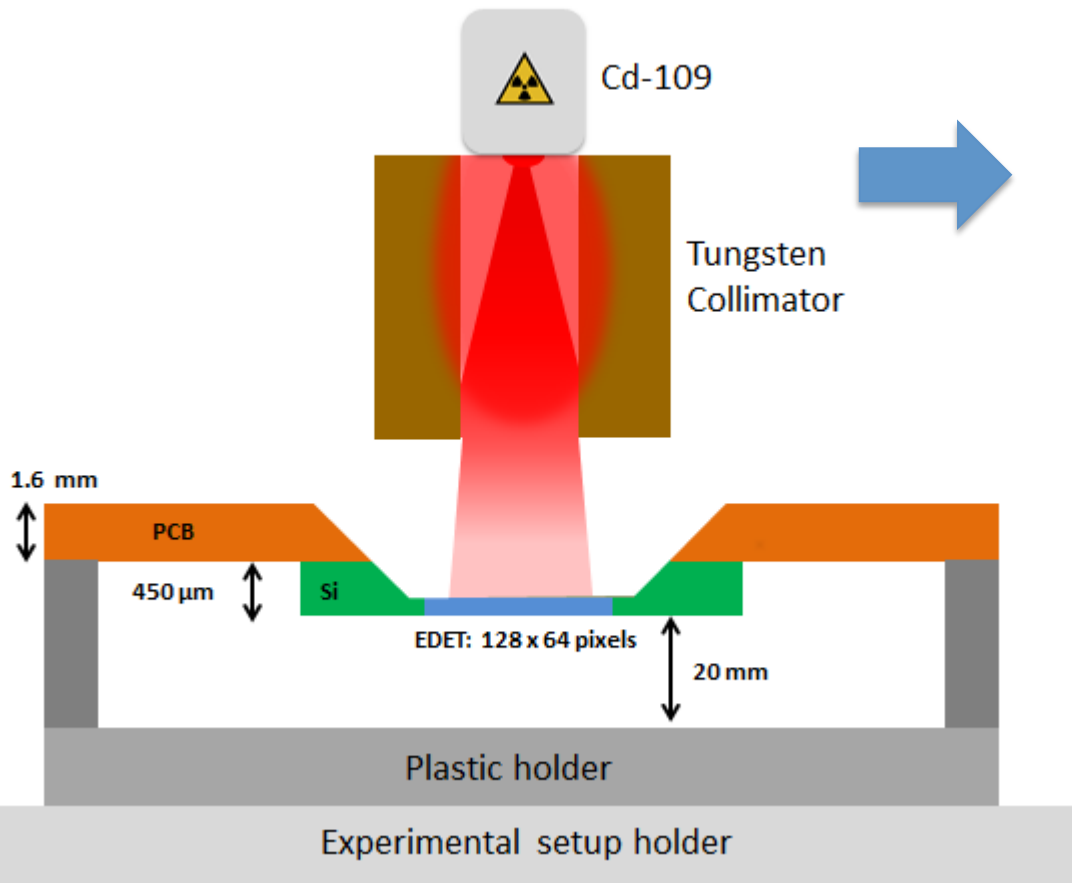
Detector	#pixel	Pixel length [mu]	A per pixel at mag. 50k	Object length at mag. 50k [mu]	Ava. Speed [fps]	Max. Speed [fps]	Sweet flux [e-/px/s]
Falcon III	20 M	14	2.8	0.41	40	->	160
K2 Summit	14 M	5	1	0.38	400	->	<2
DE-20	17 M	6.4	1.3	0.67	20-32	->	100
EDET-80	1 M	60	12	1.2	1000	80 000	20 000

G. McMullan et al, Methods in Enzymology, Volume 579, 2016

Low gain performance (Large dynamic range)



EDET calibration with Cd-109: simulation versus measurement



Mean energy of X-Rays emitted by Cd-109:

$$E_{x\text{-ray}} = 22.7 \text{ keV}$$

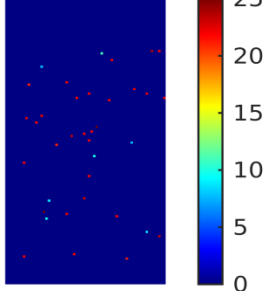
Expected peak position

- Mean energy of X-Rays emitted by Cd-109: $E_{\text{xray}} = 22.7 \text{ keV}$
- Number of e-h generated in Si : $N_e = 6270 \text{ e-h pairs}$
- Linear response region of DEPEFT: $g_q = 210.64 \text{ pA/e-}$
- Current generated by 6270 e- is : $I = 1.32 \text{ }\mu\text{A}$
- Taking into account the gain: $k=2$ (highest gain, 33): $I_d = I \times k = 1.28 \text{ (}\mu\text{A)} \times 2 = 2.64 \text{ }\mu\text{A}$
- Maximal current that can be measured by DCD of 8 bit resolution: $I_{\text{max}} = 32 \text{ }\mu\text{A}$
- **Expected peak: 21.12 ADU**

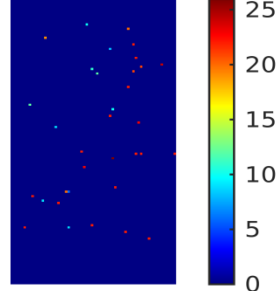


Single frames

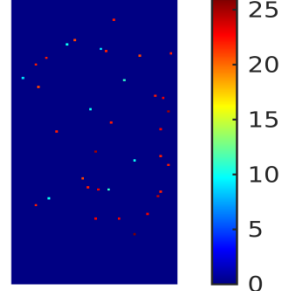
Frame #1



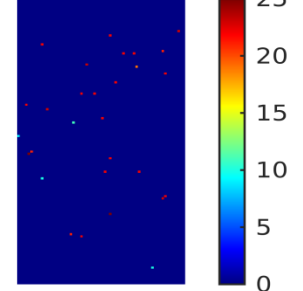
Frame #2



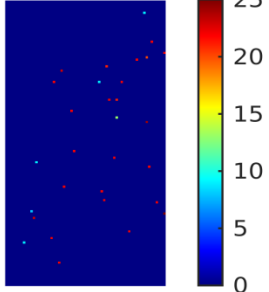
Frame #3



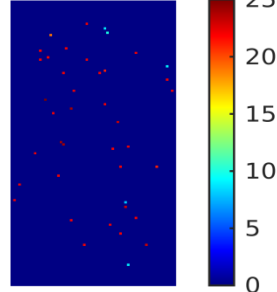
Frame #4



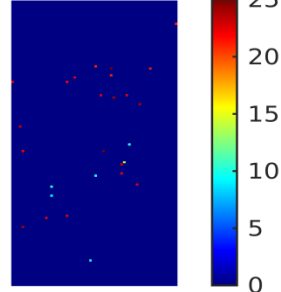
Frame #5



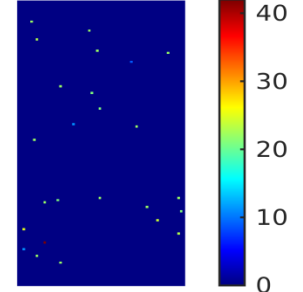
Frame #6



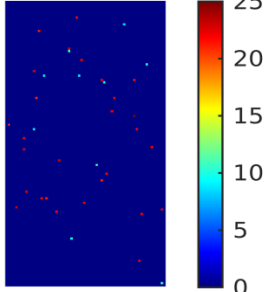
Frame #7



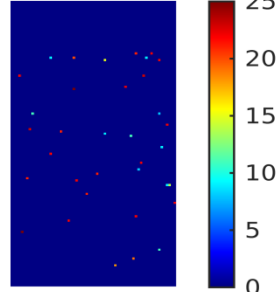
Frame #8



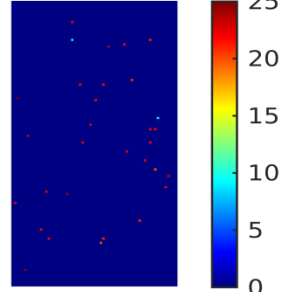
Frame #9



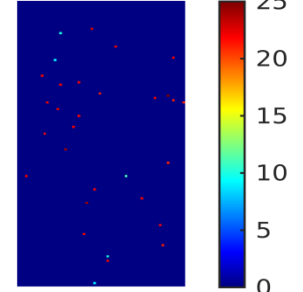
Frame #10



Frame #11

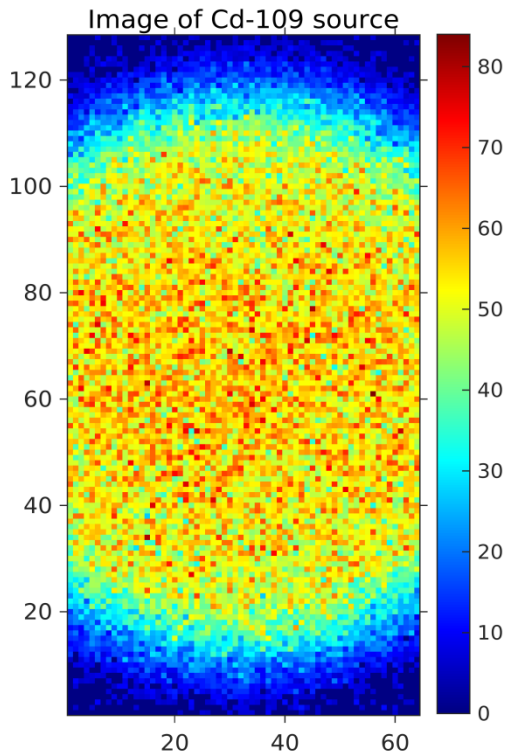


Frame #12



Simulation versus measurement counts

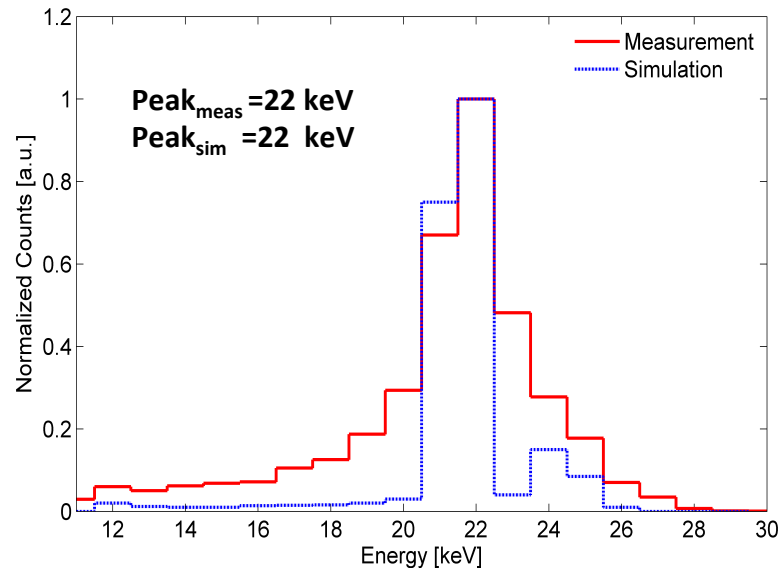
Simulation (10000 frames)



#frames = 108161326
Total Hits = 303173032

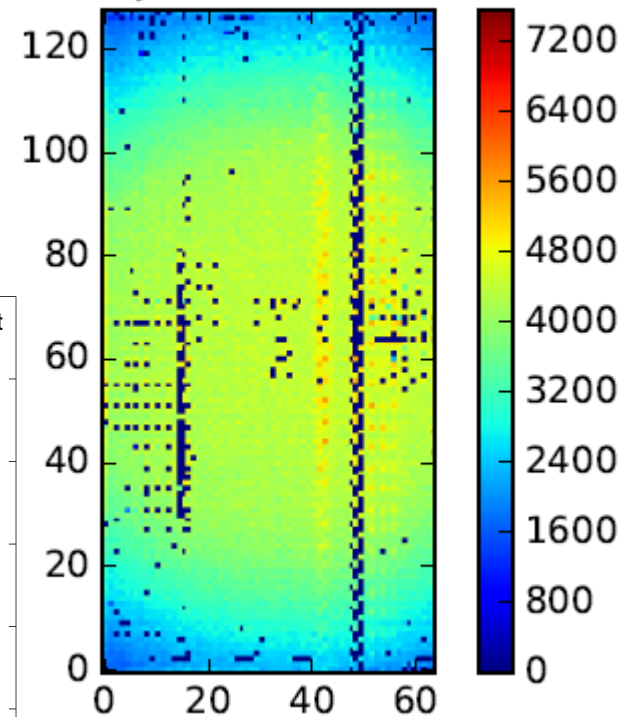
Remove noisy Pixels:
Clusters Raw = 43424961

Applying Cuts:
Clusters Filtered = 29006005



Measurement (300 M frames)

Net Intensity: Noise Mask above 3ADU
intensity-threshold = 15000 hits



Summary & Outlook

➤ Dominant source of noise in the detector: Poisson noise

➤ A competitive direct detector with improved imaging performance has been identified.

➤ EDET-80 shows great promise for TEM applications

➤ Next step: EDET imaging performance in counting mode (Higher SNR and DQE)



EDET Team: Acknowledgements

HLL ▶ Ladislav Andricek • Martin Hensel • Christian Koffmane • Jelena Ninkovic
• Gerhard Schaller • Martina Schnecke • Florian Schopper • Andreas Wassatsch
• Christian Zirr • Rainer Richter • Eduard Prinker • Rainer Richter • Mikhail Polovykh
• Mitja Predikaka • Mohammed Ibrahim

KIT ▶ Ivan Peric

USI ▶ Klaus Gärtner

MPSD ▶ Ibrahym Dourki • Sascha Epp • Djordje Gitaric • R. J. Dwayne Miller • Fabian Westermeier



**Thank you for your
attention**



En30	En60	En90	En120	Gain	Times lowest Gain
1	1	1	1	0.061	1.0
0	1	1	1	0.063	1.0
1	1	1	0	0.065	1.1
0	1	1	0	0.067	1.1
1	0	1	1	0.087	1.4
0	0	1	1	0.091	1.5
1	0	1	0	0.095	1.6
0	0	1	0	0.100	1.7
1	1	0	1	0.154	2.5
0	1	0	1	0.167	2.8
1	1	0	0	0.182	3.0
0	1	0	0	0.200	3.3
1	0	0	1	0.667	11.0
0	0	0	1	1.000	16.5
1	0	0	0	2	33

Gain k	2	1	0.667	0.2	0.182	0.167	0.154	0.1
Charge per first LSB	297	594	890	2970	3264	3557	3857	5940



EDET DATA

